



Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

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Applications

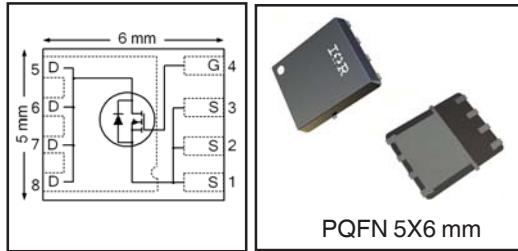
- Control MOSFET of Sync-Buck Converters used for Notebook Processor Power
- Control MOSFET for Isolated DC-DC Converters in Networking Systems

HEXFET® Power MOSFET

V_{DSS}	R_{DS(on)} max	Q_g
30V	3.5mΩ@V_{GS} = 10V	20nC

Benefits

- Very low R_{DS(ON)} at 4.5V V_{GS}
- Low Gate Charge
- Fully Characterized Avalanche Voltage and Current
- 100% Tested for R_G
- Lead-Free (Qualified up to 260°C Reflow)
- RoHS compliant (Halogen Free)
- Low Thermal Resistance
- Large Source Lead for more reliable Soldering



PQFN 5X6 mm

Base part number	Package Type	Standard Pack		Orderable part number
		Form	Quantity	
IRFH7934PBF	PQFN 5mm x 6mm	Tape and Reel	4000	IRFH7934TRPBF

Absolute Maximum Ratings

	Parameter	Max.	Units
V _{DS}	Drain-to-Source Voltage	30	V
V _{GS}	Gate-to-Source Voltage	± 20	
I _D @ T _A = 25°C	Continuous Drain Current, V _{GS} @ 10V	24	
I _D @ T _A = 70°C	Continuous Drain Current, V _{GS} @ 10V	19	A
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V	76	
I _{DM}	Pulsed Drain Current ①	190	
P _D @ T _A = 25°C	Power Dissipation ⑤	3.1	W
P _D @ T _A = 70°C	Power Dissipation ⑤	2.0	
	Linear Derating Factor ⑥	0.025	W/°C
T _J	Operating Junction and		
T _{STG}	Storage Temperature Range	-55 to + 150	°C

Thermal Resistance

	Parameter	Typ.	Max.	Units
R _{θJC}	Junction-to-Case ④	—	2.9	°C/W
R _{θJA}	Junction-to-Ambient ⑤	—	40	

Notes ① through ⑥ are on page 10

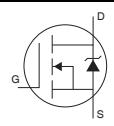
Static @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
BV_{DSS}	Drain-to-Source Breakdown Voltage	30	—	—	V	$\text{V}_{\text{GS}} = 0\text{V}, \text{I}_D = 250\mu\text{A}$
$\Delta \text{BV}_{\text{DSS}}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	0.021	—	V/ $^\circ\text{C}$	Reference to $25^\circ\text{C}, \text{I}_D = 1\text{mA}$
$R_{\text{DS}(\text{on})}$	Static Drain-to-Source On-Resistance	—	2.9	3.5	$\text{m}\Omega$	$\text{V}_{\text{GS}} = 10\text{V}, \text{I}_D = 24\text{A}$ ③
		—	4.2	5.1		$\text{V}_{\text{GS}} = 4.5\text{V}, \text{I}_D = 19\text{A}$ ③
$\text{V}_{\text{GS}(\text{th})}$	Gate Threshold Voltage	1.35	1.8	2.35	V	$\text{V}_{\text{DS}} = \text{V}_{\text{GS}}, \text{I}_D = 50\mu\text{A}$
$\Delta \text{V}_{\text{GS}(\text{th})}$	Gate Threshold Voltage Coefficient	—	-6.5	—	mV/ $^\circ\text{C}$	
I_{DSS}	Drain-to-Source Leakage Current	—	—	1.0	μA	$\text{V}_{\text{DS}} = 24\text{V}, \text{V}_{\text{GS}} = 0\text{V}$
		—	—	150		$\text{V}_{\text{DS}} = 24\text{V}, \text{V}_{\text{GS}} = 0\text{V}, T_J = 125^\circ\text{C}$
I_{GSS}	Gate-to-Source Forward Leakage	—	—	100	nA	$\text{V}_{\text{GS}} = 20\text{V}$
	Gate-to-Source Reverse Leakage	—	—	-100		$\text{V}_{\text{GS}} = -20\text{V}$
g_{fs}	Forward Transconductance	110	—	—	S	$\text{V}_{\text{DS}} = 15\text{V}, \text{I}_D = 19\text{A}$
Q_g	Total Gate Charge	—	20	30	nC	$\text{V}_{\text{DS}} = 15\text{V}$ $\text{V}_{\text{GS}} = 4.5\text{V}$ $\text{I}_D = 19\text{A}$ See Fig.17 & 18
$\text{Q}_{\text{gs}1}$	Pre-V _{th} Gate-to-Source Charge	—	4.8	—		
$\text{Q}_{\text{gs}2}$	Post-V _{th} Gate-to-Source Charge	—	2.5	—		
Q_{gd}	Gate-to-Drain Charge	—	6.3	—		
Q_{godr}	Gate Charge Overdrive	—	6.4	—		
Q_{sw}	Switch Charge ($\text{Q}_{\text{gs}2} + \text{Q}_{\text{gd}}$)	—	8.8	—		
Q_{oss}	Output Charge	—	15	—	nC	$\text{V}_{\text{DS}} = 16\text{V}, \text{V}_{\text{GS}} = 0\text{V}$
R_G	Gate Resistance	—	1.7	3.1	Ω	
$t_{\text{d}(\text{on})}$	Turn-On Delay Time	—	12	—	ns	$\text{V}_{\text{DD}} = 15\text{V}, \text{V}_{\text{GS}} = 4.5\text{V}$ $\text{I}_D = 19\text{A}$ $\text{R}_G = 1.8\Omega$ See Fig.15
t_r	Rise Time	—	16	—		
$t_{\text{d}(\text{off})}$	Turn-Off Delay Time	—	14	—		
t_f	Fall Time	—	7.5	—		
C_{iss}	Input Capacitance	—	3100	—	pF	$\text{V}_{\text{GS}} = 0\text{V}$ $\text{V}_{\text{DS}} = 15\text{V}$ $f = 1.0\text{MHz}$
C_{oss}	Output Capacitance	—	623	—		
C_{rss}	Reverse Transfer Capacitance	—	241	—		

Avalanche Characteristics

	Parameter	Typ.	Max.	Units
E_{AS}	Single Pulse Avalanche Energy ②	—	97	mJ
I_{AR}	Avalanche Current ①	—	19	A

Diode Characteristics

	Parameter	Min.	Typ.	Max.	Units	Conditions
I_s	Continuous Source Current (Body Diode)	—	—	3.9	A	MOSFET symbol showing the integral reverse p-n junction diode. 
	Pulsed Source Current (Body Diode) ①	—	—	190		
V_{SD}	Diode Forward Voltage	—	—	1.0	V	$T_J = 25^\circ\text{C}, I_s = 19\text{A}, V_{\text{GS}} = 0\text{V}$ ③
t_{rr}	Reverse Recovery Time	—	20	30	ns	$T_J = 25^\circ\text{C}, I_F = 19\text{A}, V_{\text{DD}} = 15\text{V}$
Q_{rr}	Reverse Recovery Charge	—	28	42	nC	$dI/dt = 325\text{A}/\mu\text{s}$ ③ See Fig.16
t_{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)				

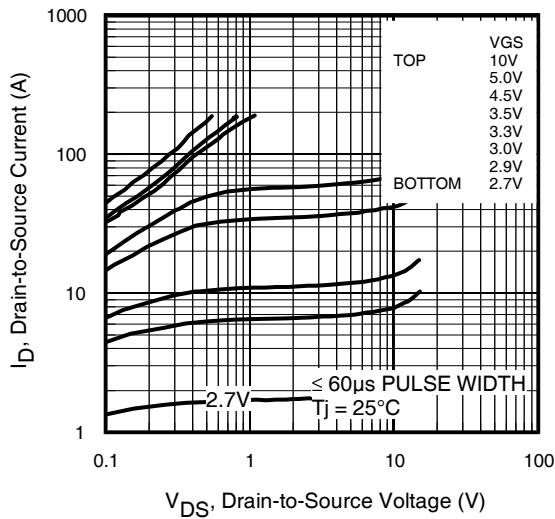


Fig 1. Typical Output Characteristics

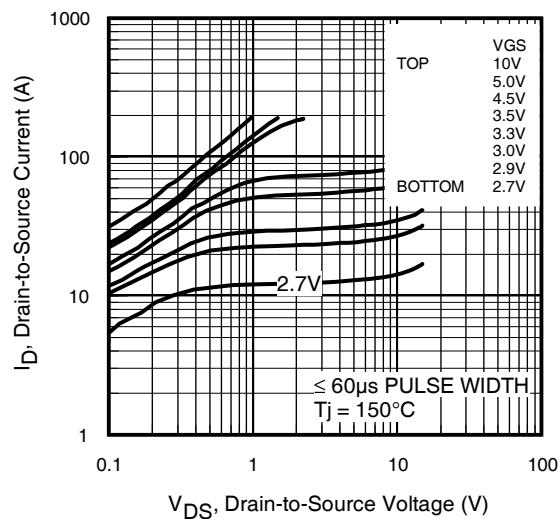


Fig 2. Typical Output Characteristics

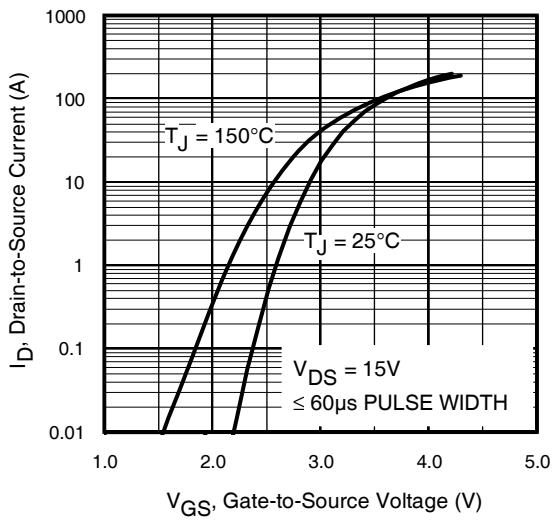


Fig 3. Typical Transfer Characteristics

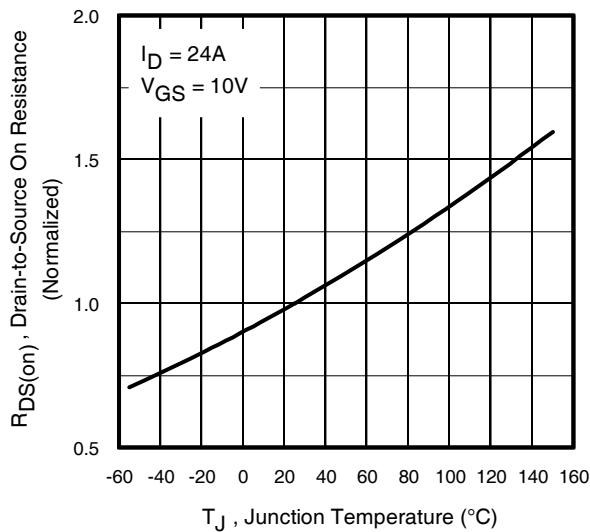


Fig 4. Normalized On-Resistance vs. Temperature

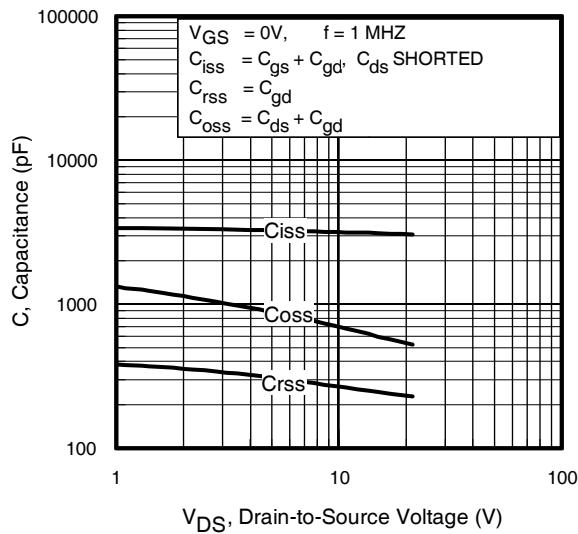


Fig 5. Typical Capacitance Vs.
Drain-to-Source Voltage

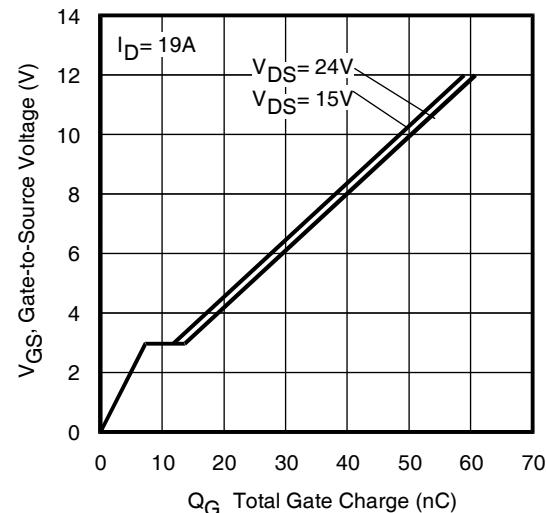


Fig 6. Typical Gate Charge vs.
Gate-to-Source Voltage

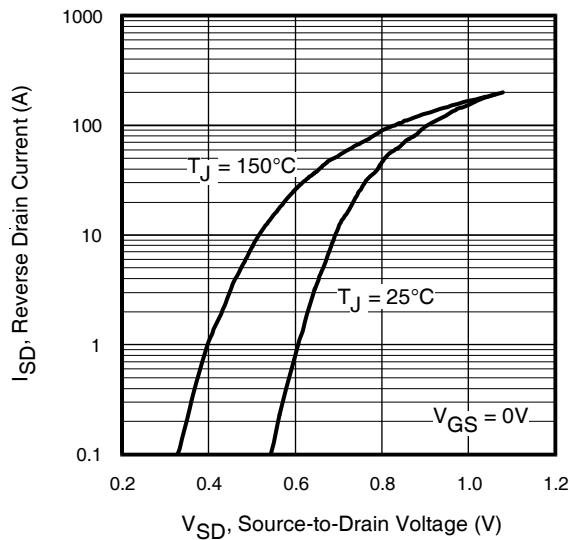


Fig 7. Typical Source-Drain Diode
Forward Voltage

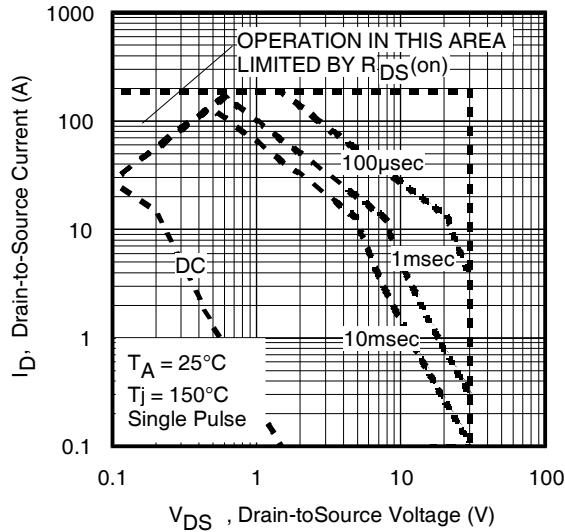


Fig 8. Maximum Safe Operating Area

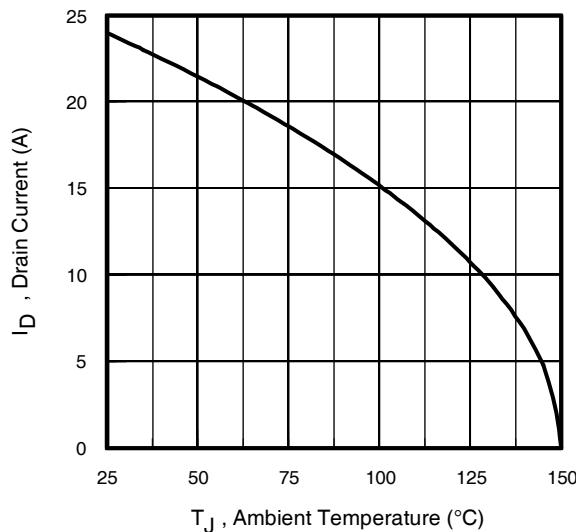


Fig 9. Maximum Drain Current vs.
Ambient Temperature

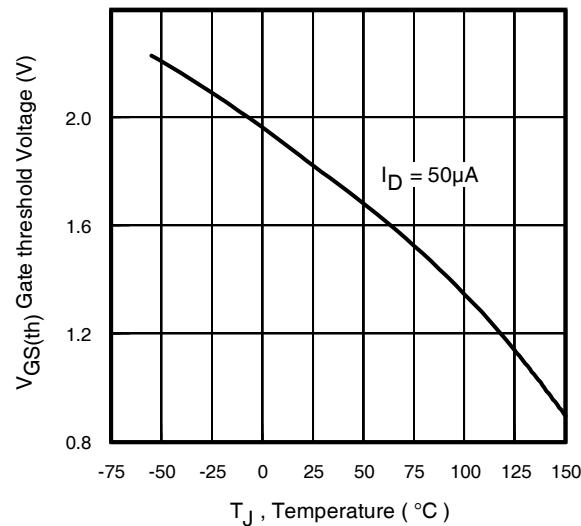


Fig 10. Threshold Voltage vs. Temperature

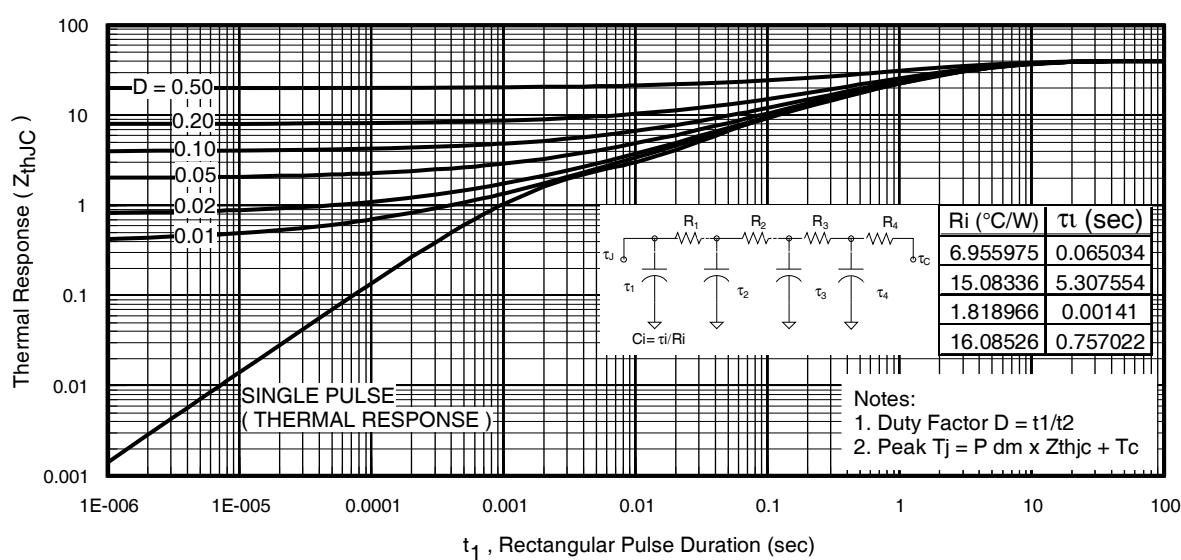


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

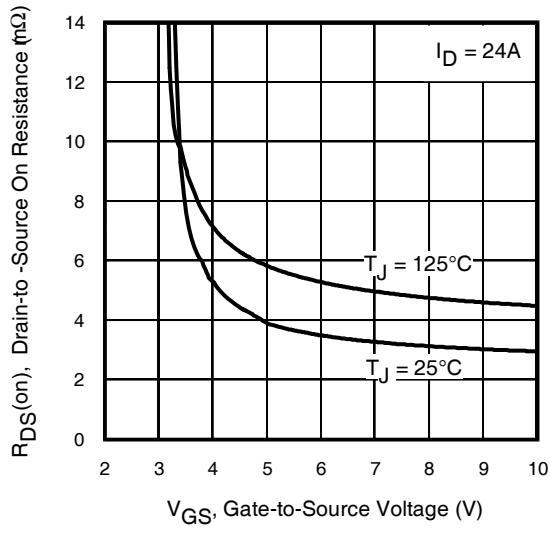


Fig 12. On-Resistance vs. Gate Voltage

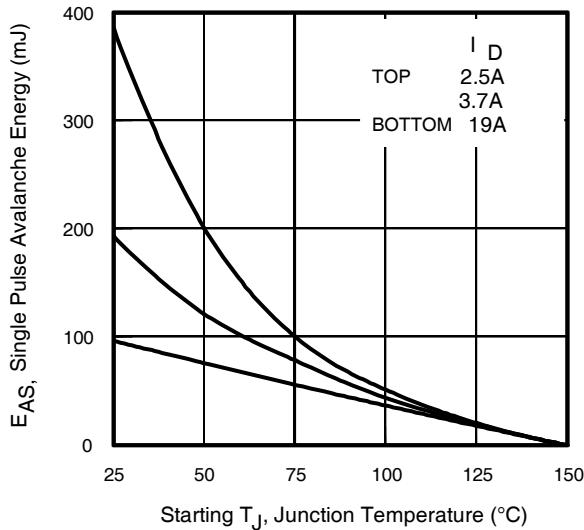


Fig 13. Maximum Avalanche Energy vs. Drain Current

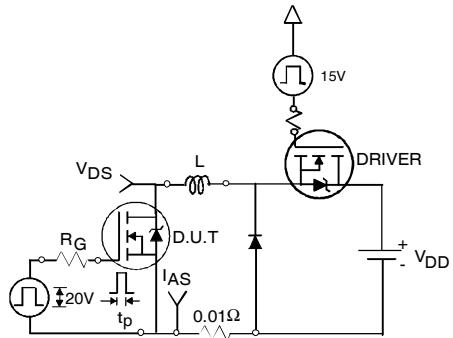


Fig 14a. Unclamped Inductive Test Circuit

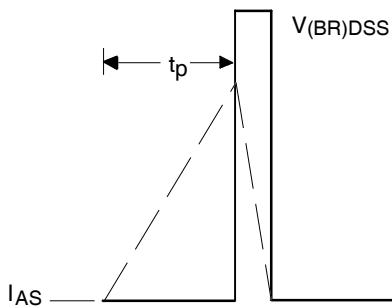


Fig 14b. Unclamped Inductive Waveforms

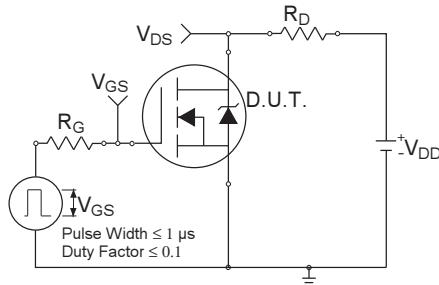


Fig 15a. Switching Time Test Circuit

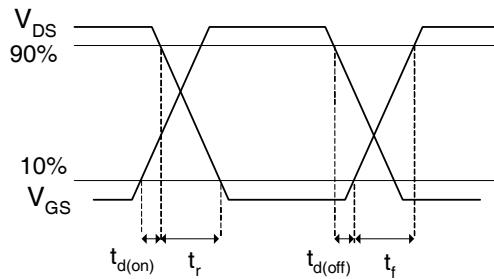


Fig 15b. Switching Time Waveforms

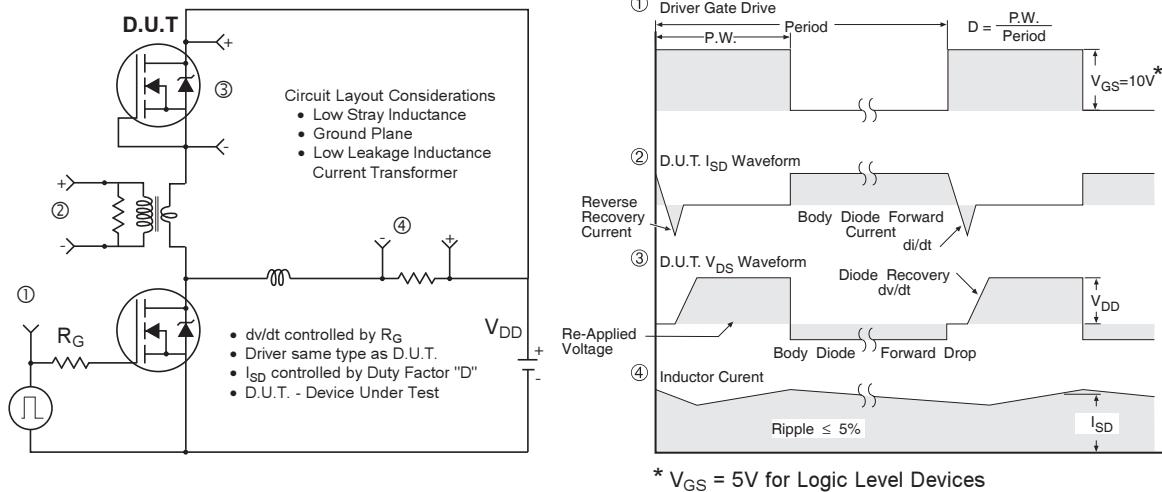


Fig 16. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

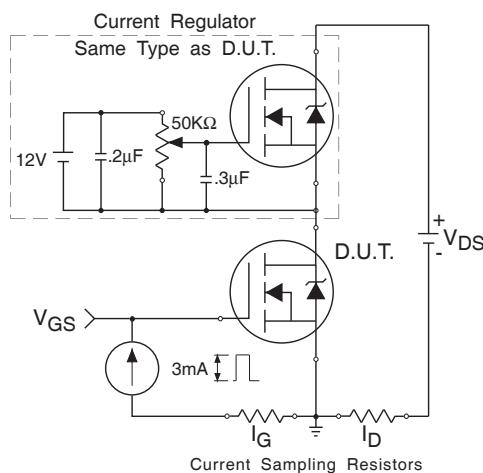


Fig 17. Gate Charge Test Circuit

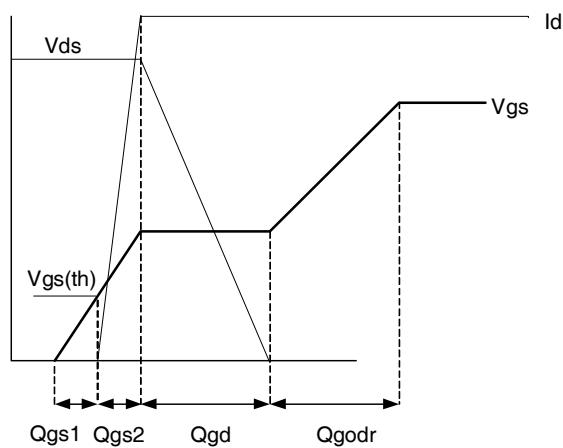
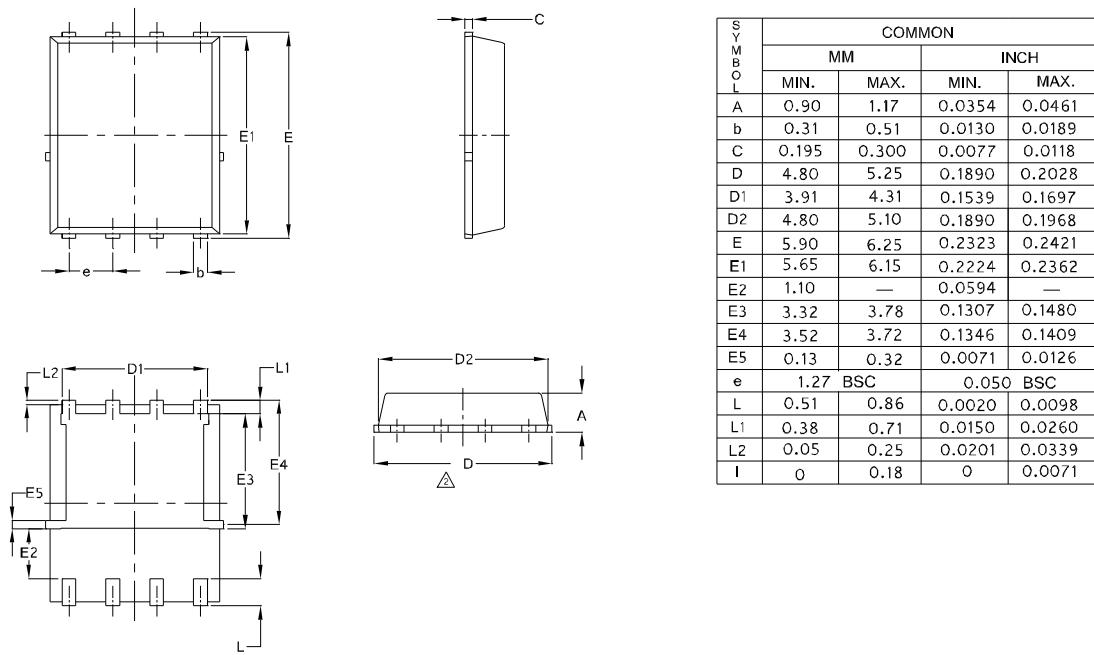
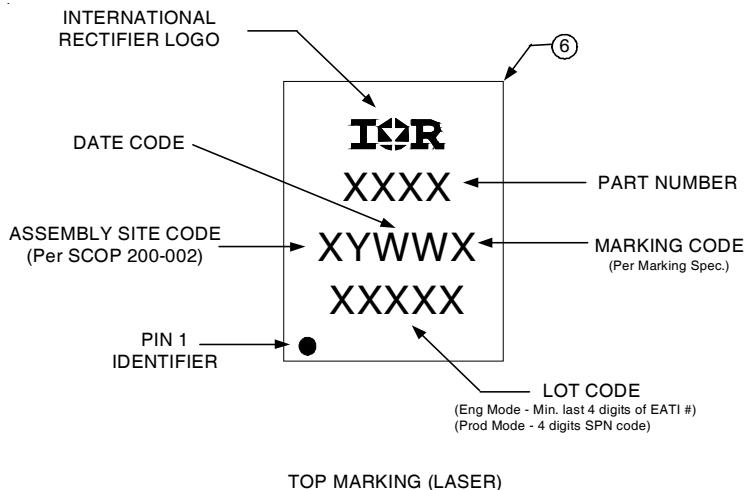


Fig 18. Gate Charge Waveform

PQFN 5x6 Option "E" Package Details

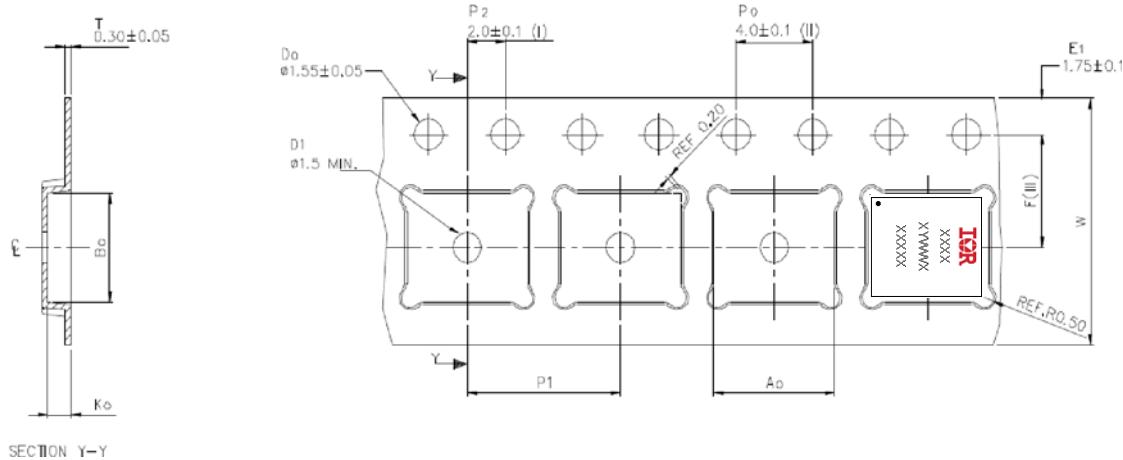


PQFN Part Marking



Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

PQFN Tape and Reel



SECTION Y-Y

A ₀	6.30 +/− 0.1
B ₀	5.30 +/− 0.1
K ₀	1.20 +/− 0.1
F	5.50 +/− 0.1
P ₁	8.00 +/− 0.1
W	12.00 +/− 0.3

- (I) Measured from centreline of sprocket hole to centreline of pocket.
- (II) Cumulative tolerance of 10 sprocket holes is ± 0.20 .
- (III) Measured from centreline of sprocket hole to centreline of pocket.
- (IV) Other material available.
- (V) Typical SR of form tape Max 10^9 OHM/SQ

ALL DIMENSIONS IN MILLIMETRES UNLESS OTHERWISE STATED.

Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>



IRFH7934PbF

Qualification information[†]

Qualification level	Consumer ^{††} (per JEDEC JESD47F ^{†††} guidelines)	
Moisture Sensitivity Level	PQFN 5mm x 6mm	MSL2 ^{††††} (per JEDEC J-STD-020D ^{†††})
RoHS compliant	Yes	

- [†] Qualification standards can be found at International Rectifier's web site
<http://www.irf.com/product-info/reliability>
- ^{††} Higher qualification ratings may be available should the user have such requirements.
Please contact your International Rectifier sales representative for further information:
<http://www.irf.com/whoto-call/salesrep/>
- ^{†††} Applicable version of JEDEC standard at the time of product release.
- ^{††††} Higher MSL ratings may be available for the specific package types listed here.
Please contact your International Rectifier sales representative for further information:
<http://www.irf.com/whoto-call/salesrep/>

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Starting $T_J = 25^\circ\text{C}$, $L = 0.535\text{mH}$, $R_G = 25\Omega$, $I_{AS} = 19\text{A}$.
- ③ Pulse width $\leq 400\mu\text{s}$; duty cycle $\leq 2\%$.
- ④ R_{thjc} is guaranteed by design
- ⑤ When mounted on 1 inch square 2 oz copper pad on 1.5x1.5 in. board of FR-4 material.

Revision History

Date	Comments
08/06/2013	<ul style="list-style-type: none">• Updated the package outline drawing, on page 8.• This drawing change is related to PCN Hana-GTBF-GEM 5x6 PQFN Public.

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IR Rectifier

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